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edited by Ronald G. Driggers.

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Preface

Optical engineers have made contributions to society to make our lives easier, safer, and more interesting. Many great technological advances in the twentieth century arose because of optical engineering.

- In 1927 Philo T. Farnsworth transmitted the first electronic television picture and Bell Telephone demonstrated the first wireless television transmission between Washington, D.C., and New York. In 1960, it is widely believed that John F. Kennedy won the U.S. presidential election based primarily on his televised performance in the Nixon-Kennedy debates. Today, there are over 1 billion television sets in operation worldwide.
- In the early 1950s, Charles Townes and Arthur Shawlow demonstrated the maser and subsequently described the possibility of the laser. In 1960, Theodore Maiman demonstrated the first laser. Today, lasers are used in surgery, welding, communications, and weapon systems. Diode lasers alone provided for a \$1.2 billion market in the year 2000.
- In the 1960s, the area of fiber optics emerged with the development of glass-clad fibers for guiding light. Today a fiber can carry 200 television channels or more than 200,000 telephone channels.
- In 1990, the Hubble Space Telescope (HST) was launched allowing researchers to investigate far-off galaxies with images previously unobtainable. To date, the HST has taken more than 330,000 separate observations and allows fundamental research on universe expansion.
- In the past few decades, optical systems for precision targeting, intelligence, surveillance, reconnaissance, and night vision have provided huge advantages on the battlefield. Infrared and electro-optical systems have been key instruments in the success of wartime operations such as Desert Storm and Enduring Freedom. Today, these systems are used to protect countries and project military power.

Classical engineering disciplines include electrical, mechanical, civil, and some areas of chemical engineering. Computer engineering, although not "classical," all but exploded in the last quarter century and is now a well-established discipline. I consider an engineering discipline to be an area in which an individual can spend a lifetime of work; it is supported by academia, industry, government, and professional societies. Optical engineering is an engineering discipline but has yet to have individual academic departments devoted to it. It may be that the physics community holds dearly the interaction of light and matter, and, as a result, provides supporting academic programs in the fields of optical sciences and photonics. The graduates of these programs frequently find themselves working in optical engineering.

Before I continue, let me explain why I consider myself an optical engineer. While my formal training is that of an electrical engineer, I have not seen a wire or a transistor for at least 10 years. Both my undergraduate and graduate programs had a number of courses in electro-optics. Many electrical engineering programs around the country have courses in electro-optics, and a couple of schools have created a specialization or concentration in electro-optics. Graduate courses in electro-optics (and laser systems) are usually attended by both electrical

engineering students and physics students. However, the physics programs that include these courses are typically called optical sciences or photonics programs. Before it sounds as though I am biased, let me state that both engineers and physicists make excellent optical engineers.

Optical engineering is concerned with the engineering of a device or system in which light is involved, while *Photonics* is concerned primarily with the basic interaction of light and matter. But there is a large overlap between the two. Episodes from television's classic "Star Trek" series show that Scotty the engineer could not get the ship's systems running until Mr. Spock provided some basic science that converted a fundamental problem to a practical solution. Such is the case with optical engineering and photonics.

The purpose of this encyclopedia is to provide an optical engineering reference that can be used by engineers, physicists, and other scientists. The target length for each entry was set at around 6000 words, but many of the entries exceed this length. Authors were asked to review fundamentals of each topic. No derivations were requested. Around 50 areas were identified as important for the first issue and Topical Editors were recruited to solicit and edit articles related to these areas, ranging from adaptive optics to x-ray optics.

This encyclopedia provides dual products: digital encyclopedia via the Internet and a print encyclopedia. The online version is a living document that grows with quarterly updates, and timely content is continually added to make the work dynamic. Suggestions for new content will be welcomed; they should be directed to me at the e-mail address listed below. The printed version will be updated through new editors.

I want to thank three groups of people for my participation in this worthy project. First are the people who had a hand in making me an optical engineer: Carl Halford, Glenn Boreman, the late John Nestler, Luc Biberman, Eddie Burroughs, Ray Deep, Gerry Holst, Rich Vollmerhausen, Tim Edwards, Jim Ratches, Dean Scribner, and Jon Leachtenauer. These people have my admiration, respect, and loyalty. They are truly the cream of the crop in the area of optical engineering, and I am very grateful for the opportunities that I have had to learn from them.

Second, I would like to thank the people who worked hard to initiate the project and make the encyclopedia a success. Thanks goes to Marcel Dekker, Inc., for getting the project off the ground. I appreciate the confidence of Glenn Boreman, Barry Johnson, and Russell Dekker in my ability to accomplish this mammoth project. This encyclopedia would not have been possible without their efforts. Although I did not share my appreciation with her enough, Ellen Lichtenstein (Encyclopedia Editor) was helpful and caring throughout the project. The work of Alison Cohen was also appreciated more than she knows. The work of all the Topical Editors and authors is very much appreciated. Our Topical Editors have been superb mentors in identifying encyclopedia content; their participation improved the resulting product significantly. Many of the entries are amazing in that they provide the fundamental concepts, give technical applications, and are a joy to read.

Third and most important, I would like to thank my family for the time and support to accomplish this project. My beautiful and inspirational wife, Rita, a famous OB/GYN doctor at Johns Hopkins, supports everything that I pursue. My eldest son, Ryan, and the Drigglets (Megan, Madison, and Buddy) gave me a chaos-management experience that served me well in managing encyclopedia tasks. Their lives are far more interesting than my own and I have been blessed to be a part of them. My closest brother, Keith Krapels, is not of blood, but of the experience of sharing a majority of our lives together. It is because of these people that I do not mind growing older since the process means spending time with them.

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Contents

Volume 1

Aberrations / Virendra N. Mahajan and Pantazis Z. Mouroulis	1
Active Matrix Liquid Crystal Displays (LCDs) / Kevin L. Walsh	26
Adjacency Effect / Eric F. Vermote 3	39
Aerosols / Arkadi Zilberman	19
Artificial Media Optical Properties—Subwavelength Scale / Philippe Lalanne and	
Mike Hutley	
Astronomy / James R. Sowell and Donald Bord	
Atmospheric Blur and Image Restoration / N. S. Kopeika	
Atmospheric Optics / N. S. Kopeika	98
Automatic Target Detection / Lipchen Alex Chan, Sandor Z. Der, and Nasser M. Nasrabadi	01
Automatic Target Recognition / Gary O'Brien	
Avalanche Photodetectors / Vitaly E. Shubin and Dmitry A. Shushakov	2 !
Backscatter / Fernando Moreno, Jose M. Saiz, and Francisco González 14	42
Biological Models for Image Information / Jason M. Kinser	5
Biomedical Spectroscopy / Valery V. Tuchin	66
Birefringence / Myrian Tebaldi	8:
Bonded Optics, Optimizing the Performance of / Andrew G. Bachmann, Nicole Langer, John R. Arnold, and John G. Daly	0
Cavity Quantum Electrodynamics / H. Walther	
Circular Polarization Filters / Akhlesh Lakhtakia and Martin W. McCall	3(
Coherence—General / Ichirou Yamaguchi	3
Coherence Theory / William H. Carter	4
Complex Variables / Thomas L. Clarke	6
Compression of Digital Images / Mark S. Schmalz	70
Compression Transforms—Hierarchical Including Wavelets / François G. Meyer	7
Correlator—Compact Real-Time / Aris Tanone	9
Delta T (Differential Blackbody Temperature) / J. Glen Vinson	1.
Detector Focal Plane Array Technology / Paul Norton	2
Detectors—Figures of Merit / Panos G. Datskos and Nickolay V. Lavrik	4
Diffraction Methods / Dennis W. Prather	5
Diffractive Optics / Joseph N. Mait	6
Diffractive Optics Fabrication / Thomas J. Suleski	7
Digital Image Enhancement / Nikolas P. Galatsanos, C. Andrew Segall, and Aggelos K. Katsaggelos	8
Digital Image Processing / Russell C. Hardie and Majeed M. Hayat	

Digital Image Restoration—Classical / C. Andrew Segall and Aggelos K. Katsaggelos	. 411
Distortion / Laurence G. Hassebrook and Chun Guan	
Doppler-Free Spectroscopy / Susan K. Watson	. 435
Electro-Optical Imaging System Performance Measurement / Piet Bijl,	
Alexander Toet, and J. Mathieu Valeton	
Electro-Optical Materials / Jean-Pierre Huignard and Jean-Paul Pocholle	. 451
Electro-Optical Scanners / Daniel D. Stancil	. 456
Emissivity Measurements Using Infrared Imaging Radiometric Cameras / Robert P. Madding	475
Extreme Ultraviolet Lithography / Donald W. Sweeney	. 485
Eye Movements and Accommodation / Nicklaus F. Fogt	. 492
Fiber Optic Sources / Geert Morthier	511
Fiber Optics—Characteristics / John Gowar	519
Fiber Optics/Optical Communications / John Gowar	534
Fluorescence Microscopy / Kenneth R. Spring	548
F-Number, Numerical Aperture, and Depth of Focus / John Hall	
Forward Looking Infrared (FLIR) / Bill Blecha	
Fourier Data Processing in Optics / Zeev Zalevsky, David Mendlovic, Gal Shabtay,	
and Uriel Levy	569
Fourier Optics and Optical Signal Processing / Joseph Shamir	585
Fourier Spectrometer / Romuald Jozwicki	598
Fourier Transform Infrared Spectroscopy / Xudong Xiao and Bing Wang	
Fresnel Lens / Michael D. Watson and Steven M. Scott	
Galaxies / William Keel	
Gas Lasers / Robert C. Sze	
Glass Waveguide Fabrication / Giancarlo C. Righini	
Glass—Working Optical Applications / Hedser van Brug	
Gradient Index (GRIN) Lenses / Andrew B. Tsiboulia	
High-Density Data Storage—New Prospects / Claire Gu	
High Power Femtosecond Pulses / Victor Yanovsky	
Holographic Storage / Geoffrey W. Burr	
Holography / H. John Caulfield	735
Human Vision and Color / Brian H. Tsou and Vincent A. Billock	748
Illumination Optics / Richard Heinisch	
Image Compression Applications / Liviu I. Voicu	773
Image Compression with the JPEG-2000 Standard / Christopher M. Brislawn and Mihaela D. Quirk	780
Image Intensifiers / C. Bruce Johnson	
Image Quality Equations and NIIRS / Jon C. Leachtenauer	
Image Quality Measures for Compression Transforms / Frank M. Caimi and Mark S. Schmalz	
Image Segmentation / Mauro Barni and Franco Bartolini	
Image Sequence Processing / Robert L. Stevenson and Sean Borman	
Industrial Lasers / Leonard R. Migliore	
Infrared Detectors and Focal Plane Arrays / Masafumi Kimata	
Infrared Imaging Systems / Keith Krapels	
Integral Transforms / Mikhail S. Belen'kii	

Integrated Optical Circuits / Ari Tervonen	926
Integrated Optical Waveguides / Cheng-Chung Li	937
Interference / John Hayes	945
Intracavity Laser Spectroscopy of Molecules / L. N. Sinitsa	966
Iterated Function Systems / Michael F. Barnsley	976
Joint Transform Correlator / Suganda Jutamulia	984
Laser-Cooled Atoms and Optical Lattices / Gilbert Grynberg	990
Laser and Gaussian Beam Propagation and Transformation / Javier Alda	999
Laser Transmitters / Osamu Wada	1014
Volume 2	
Lasers / Bradley W. Schilling	1025
Lasers for Biomedical Applications / Lars O. Svaasand	1035
Lasers in Medicine / Stephen N. Joffe	1045
Lens Design / Deging Ren	
Lenses, Mirrors, and Prisms / R. Hradaynath and Ikbal Singh	1068
Lidar—Aerosol Sensing / Francesc Rocadenbosch	1090
Lidar—Remote Sensing / Matthew J. McGill	1103
Lidar—Wind, Raman, and Other Sensing / Francesc Rocadenbosch	1114
Liquid Crystals—Cholesteric, Guest-Host, and Polymer-Dispersed Liquid Crystal Devices / Sven T. Lagerwall, Per G. Rudquist, and David S. Hermann	
Liquid Crystals—New Electro-Optic Modes and Applications / Sven T. Lagerwall, Per G. Rudquist, and David S. Hermann	
Liquid Crystals—Nonlinear Optical Effects in Liquid Crystals / Sven T. Lagerwall, Per G. Rudquist, and David S. Hermann	
Liquid Crystals—Optical Properties and Basic Devices / Sven T. Lagerwall, Per G. Rudquist, and David S. Hermann	
Lossless Image Compression / S. Sahni, B. C. Vemuri, F. Chen, C. Kapoor, C. Leonard, and J. Fitzsimmons	
Lossy Blockwise Image Compression / Thomas H. Drayer	
Machine Vision / Bruce Batchelor	
Machine Vision—Image Processing / E. R. Davies	
Machine Vision—Lighting / Kevin G. Harding	1227
Magnetic Resonance Imaging / Jan Sijbers and Annemie Van der Linden	1237
Material Properties of III-V Semiconductor Material:	
Nonlinear Optical Characteristics / R. Kuszelewicz and A. Levenson	1259
Materials—Electro-Optic Inorganic / Angel García Cabañes, José Manuel Cabrera Castillo, and Fernando Agulló López	1271
Medical X-Rays / J. Anthony Seibert	1284
Metrology / Michael Friedmann	1307
Microscopy of Living Cells, Tissues, and Organs / Robert S. McCuskey	1319
Microwave Spectroscopy / Alan C. Samuels	1329
Military Imaging Experiments / Barbara L. O'Kane	1340
Milky Way / Richard Sears	1348
Modulation Transfer Function (MTF) / Arnold Daniels	1357
Molding of Optical Components / R. Wimberger-Friedl	1368
Motion Percention / Scott N. J. Watamaniuk	